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Precision Metrology Using Ultrashort Pulse Laser and Optical Frequency Comb

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Message from the Guest Editors

This Special Issue aims to address to all types of sensors, measuring instruments, and measurement technologies based on the ultrashort pulse laser and optical frequency comb for precision measurement, including but not limited to:

- The measurement of length, thickness, distance, and strain, angle;
- The measurement of linear/angular displacement, velocity, and acceleration;
- The measurement of surface form and surface texture:
- The measurement of the external and internal 2D/3D structures of biological and nonbiological materials;
- The measurement of diffractive index and the mechanical properties of materials;
- Microscopy using an ultrashort-pulse laser source and the optical frequency comb;
- Optical frequency comb spectroscopy;
- The development of a visible/infrared ultrashort pulse laser source;
- The phase stabilization of the optical frequency comb;
- Related measurement standards and traceability.













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Message from the Editor-in-Chief

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